

Notice of References Cited	Application/Control No. 10/644,215	Applicant(s)/Patent Under Reexamination EMMOT ET AL.	
	Examiner Ulka J. Chauhan	Art Unit 2676	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,448,698 A	09-1995	Wilkes, Andrew J.	709/245
	B	US-5,920,326 A	07-1999	Rentschler et al.	345/503
	C	US-5,951,672 A	09-1999	Kwok et al.	712/28
	D	US-6,181,346 B1	01-2001	Ono et al.	345/582
	E	US-6,292,200 B1	09-2001	Bowen et al.	345/506
	F	US-6,377,257 B1	04-2002	Borrel et al.	345/419
	G	US-6,384,833 B1	05-2002	Denneau et al.	345/522
	H	US-6,725,296 B2	04-2004	Craddock et al.	710/52
	I	US-6,762,763 B1	07-2004	Migdal et al.	345/506
	J	US-6,771,269 B1	08-2004	Radecki et al.	345/503
	K	US-6,819,325 B2	11-2004	Boyd et al.	345/559
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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